

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/790,248	YONEDA, KIYOSHI	
		Examiner	Art Unit	Page 1 of 1
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	C	US-2003/0156079	08-2003	Nakanishi, Hayato	345/45
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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